



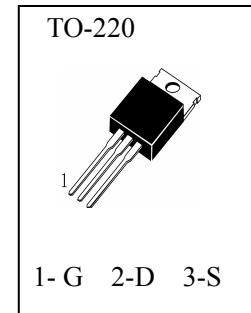
Shantou Huashan Electronic Devices Co., Ltd.

HFP7N60

N-Channel Enhancement Mode Field Effect Transistor

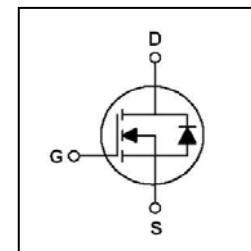
■ General Description

These are N-Channel enhancement mode silicon gate power field effect transistors. They are advanced power MOSFETs designed, this advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode . These devices are well suited for high efficiency switch mode power supply, power factor correction, electronic lamp ballast based on half bridge.



■ Features

- 7A, 600V(See Note), $R_{DS(on)} < 1.2\Omega$ @ $V_{GS} = 10$ V
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability
- RoHS compliant



■ Maximum Ratings (Ta=25°C unless otherwise specified)

| | |
|--|-----------|
| T _{stg} —— Storage Temperature ----- | -55~150°C |
| T _j —— Operating Junction Temperature ----- | 150°C |
| V _{DSS} —— Drain-Source Voltage ----- | 600V |
| V _{GSS} —— Gate-Source Voltage ----- | ±30V |
| I _D —— Drain Current (Continuous)(T _c =25°C) ----- | 7A |
| I _{DM} —— Pulsed Drain Current (Note 1)----- | 28A |
| P _D —— Maximum Power Dissipation (T _c =25°C) ----- | 147W |
| Derate Above 25°C ----- | 1.18W/°C |
| E _{AS} —— Pulsed Avalanche Energy (Note 2) ----- | 420mJ |
| I _{AR} —— Avalanche Current (Note 1) ----- | 7A |
| E _{AR} —— Repetitive Avalanche Energy (Note 1) ----- | 14.7mJ |
| dv/dt —— Peak Diode Recovery dv/dt (Note 3) ----- | 5.5V/ns |

■ Thermal Characteristics

| Symbol | Items | TO-220 | Unit |
|-----------------------|-------------------------------------|----------|------|
| R _{thj-case} | Thermal Resistance Junction-case | Max 0.85 | °C/W |
| R _{thj-amb} | Thermal Resistance Junction-ambient | Max 62.5 | °C/W |



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■ Electrical Characteristics (Ta=25°C unless otherwise specified)

| Symbol | Items | Min. | Typ. | Max. | Unit | Conditions |
|---|---|------|------|------|--|--|
| Off Characteristics | | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | 600 | | | V | I _D =250μA , V _{GS} =0V |
| I _{DSS} | Zero Gate Voltage Drain Current | | 1 | μA | V _{DS} =600V, V _{GS} =0V | |
| | | | 10 | μA | V _{DS} =480V, V _{GS} =0V,T _j =125°C | |
| I _{GSS} | Gate – Body Leakage | | | ±100 | nA | V _{GS} = ±30V , V _{DS} =0V |
| On Characteristics | | | | | | |
| V _{GS(th)} | Gate Threshold Voltage | 2.0 | | 4.0 | V | V _{DS} = V _{GS} , I _D =250μA |
| R _{DS(on)} | Static Drain-Source On-Resistance | | 0.91 | 1.2 | Ω | V _{GS} =10V, I _D =3.5A |
| Dynamic Characteristics and Switching Characteristics | | | | | | |
| C _{iss} | Input Capacitance | | 1250 | 1620 | pF | V _{DS} = 25 V, V _{GS} = 0V, f = 1.0 MHz |
| C _{oss} | Output Capacitance | | 120 | 156 | pF | |
| C _{rss} | Reverse Transfer Capacitance | | 17.5 | 22.5 | pF | |
| t _{d(on)} | Turn - On Delay Time | | 20 | 40 | nS | V _{DS} = 300V, I _D =7A, R _G = 25 Ω (Note 4,5) |
| t _r | Rise Time | | 55 | 110 | nS | |
| t _{d(off)} | Turn - Off Delay Time | | 90 | 180 | nS | |
| t _f | Fall Time | | 60 | 120 | nS | |
| Q _g | Total Gate Charge | | 30 | 40 | nC | V _{DS} =480V, ID=7A, V _{GS} = 10 V (Note 4,5) |
| Q _{gs} | Gate–Source Charge | | 6 | | nC | |
| Q _{gd} | Gate–Drain Charge | | 13 | | nC | |
| Drain-Source Diode Characteristics and Maximum Ratings | | | | | | |
| I _S | Continuous Source–Drain Diode Forward Current | | | 7 | A | |
| I _{SM} | Pulsed Drain-Source Diode Forward Current | | | 28 | A | |
| V _{SD} | Source–Drain Diode Forward On–Voltage | | | 1.4 | V | I _S =7A,V _{GS} =0 |

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature
2. L=15.7mH,I_{AS}=7.0A, V_{DD}=50V, R_G=25 Ω ,Starting T_j=25°C
3. I_{SD}≤7.0A, di/dt≤300A/μS,V_{DD}≤BV_{DSS}, Starting T_j=25°C
4. Pulse Test: Pulse width≤300μS, Duty Cycle≤2%
5. Essentially independent of operating temperature



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■ Typical Characteristics

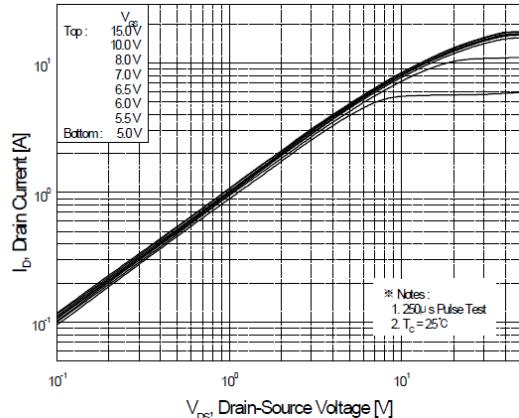


Figure 1. On-Region Characteristics

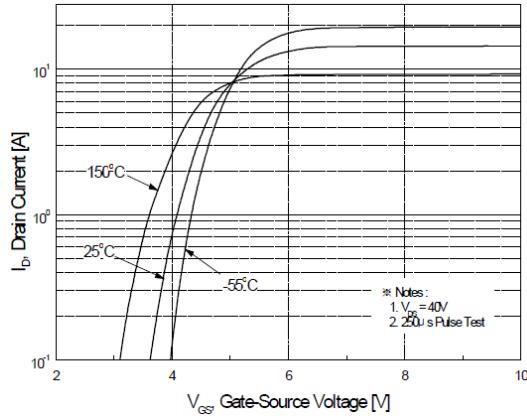


Figure 2. Transfer Characteristics

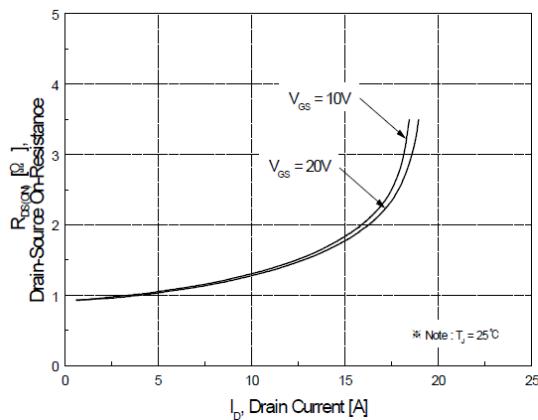


Figure 3. On-Resistance Variation vs
Drain Current and Gate Voltage

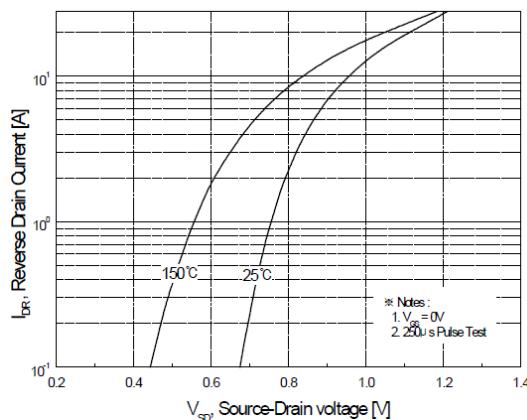


Figure 4. Body Diode Forward Voltage
Variation with Source Current
and Temperature

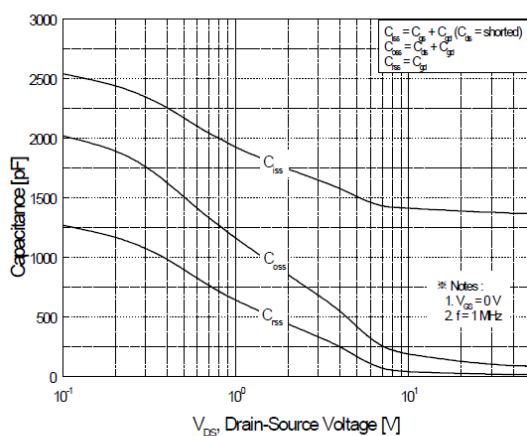


Figure 5. Capacitance Characteristics

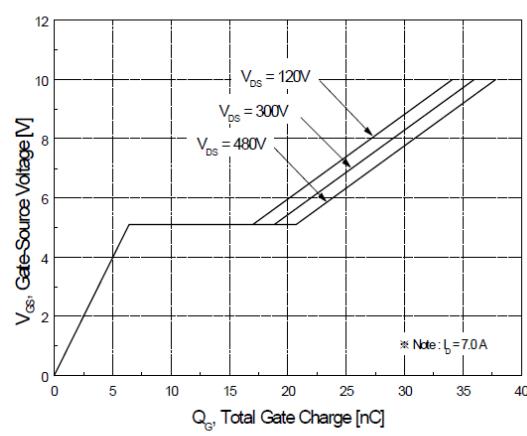


Figure 6. Gate Charge Characteristics



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■ Typical Characteristics

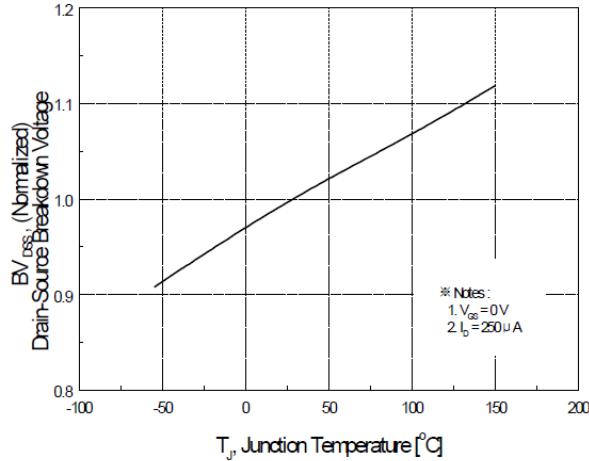


Figure 7. Breakdown Voltage Variation
vs Temperature

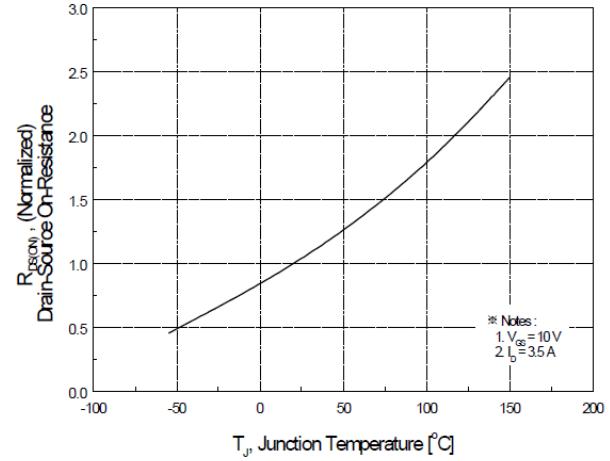


Figure 8. On-Resistance Variation

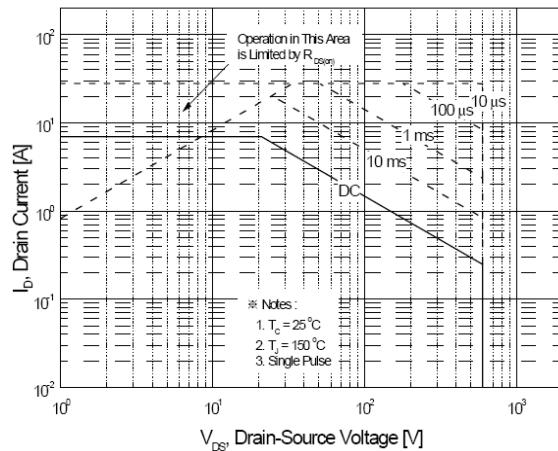


Figure 9. Maximum Safe Operating Area

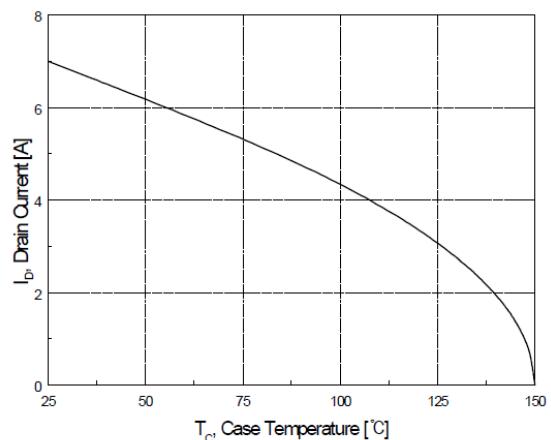


Figure 10. Maximum Drain Current
vs Case Temperature

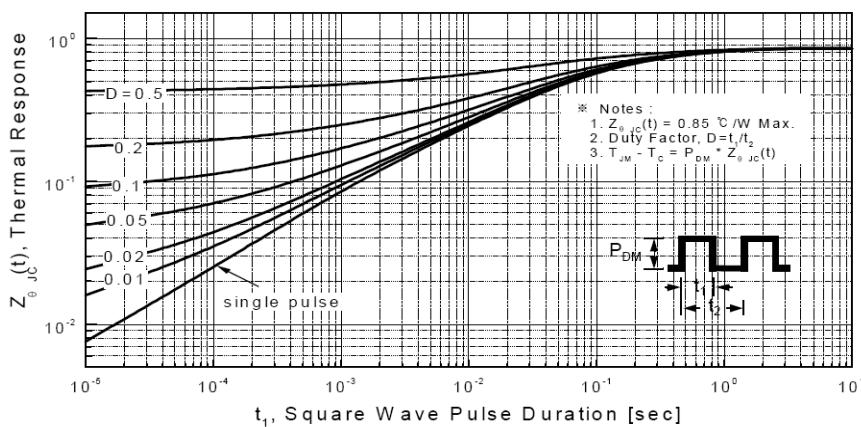


Figure 11. Transient Thermal Response Curve



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■ Typical Characteristics

Fig 12. Gate Charge Test Circuit & Waveform

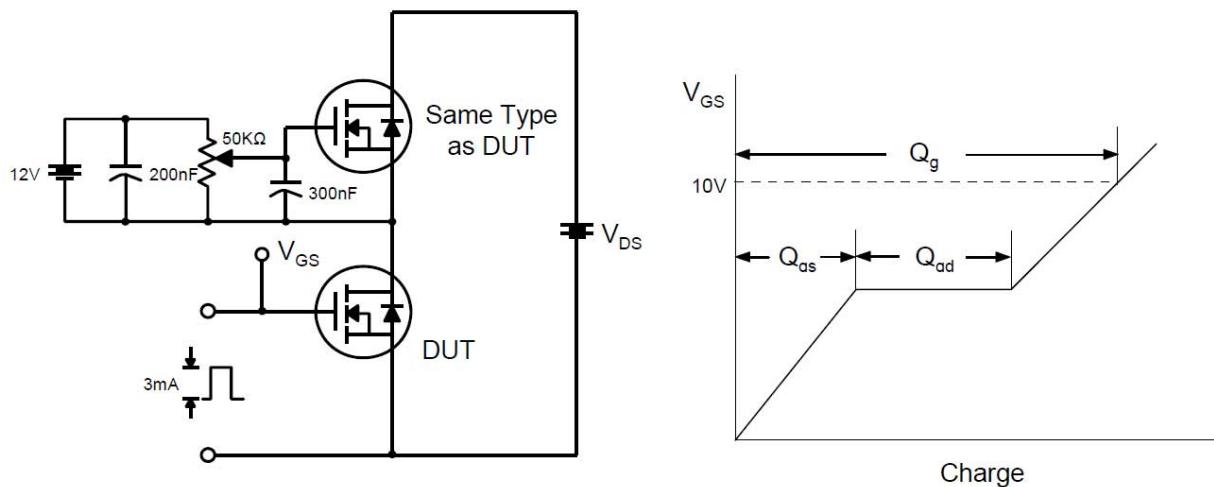


Fig 13. Resistive Switching Test Circuit & Waveforms

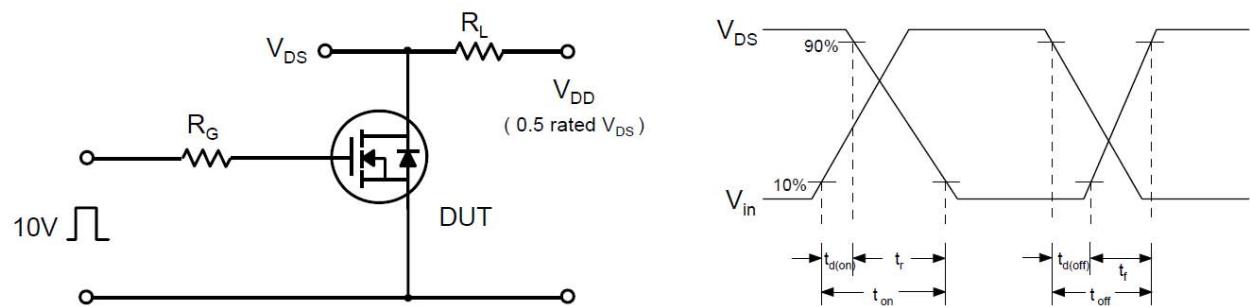
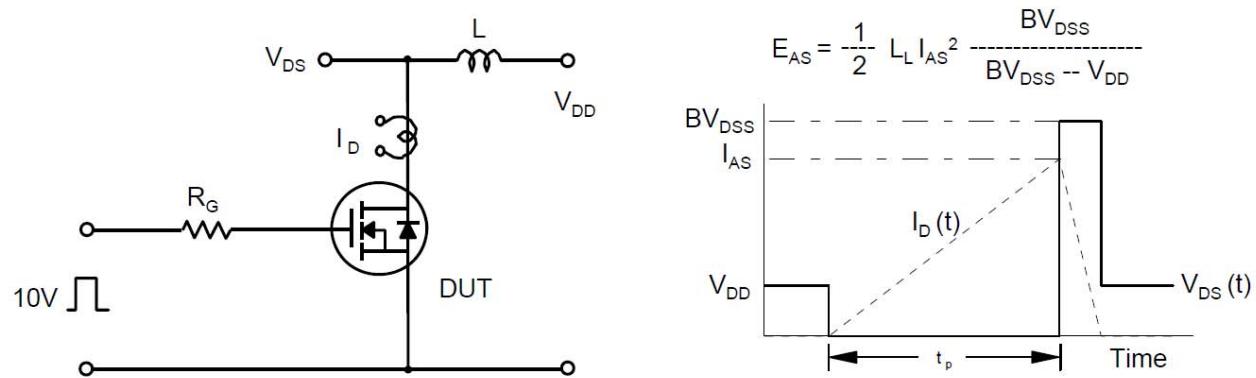


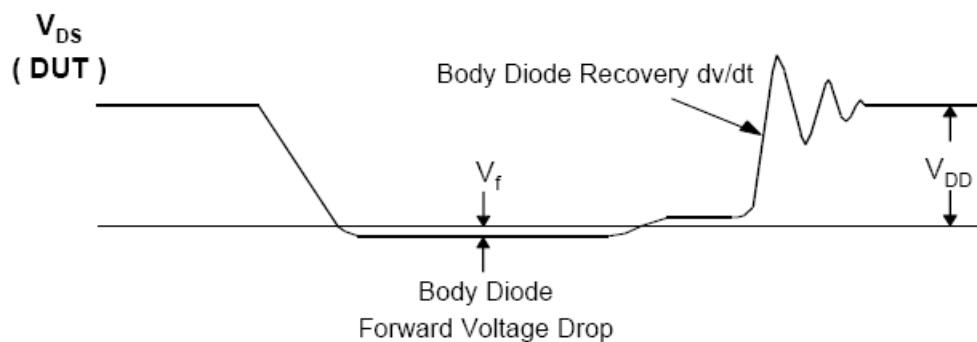
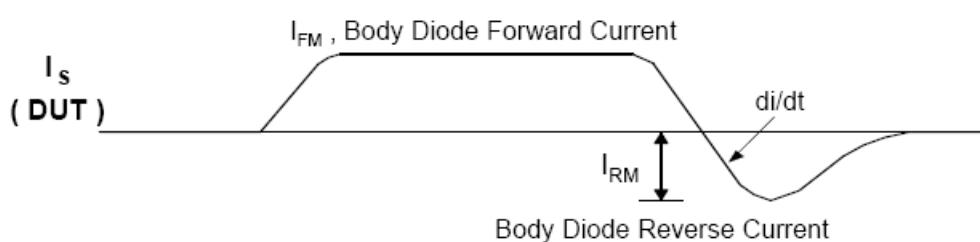
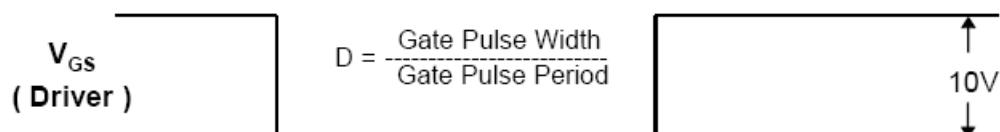
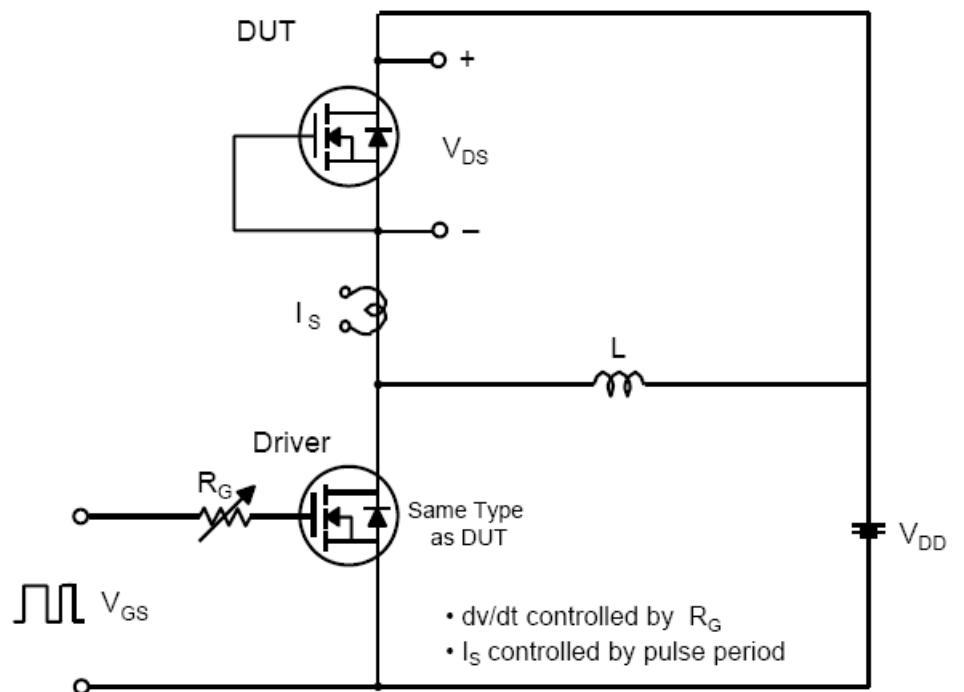
Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms





■ Typical Characteristics

Fig 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms





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■ Package Dimensions

